DATA SHEET

BFT25A
NPN 5 GHz wideband transistor

Product specification
File under Discrete Semiconductors, SC14

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Philips Semiconductors

PHILIPS

NPN 5 GHz wideband transistor — BFT25A

FEATURES

- Low current consumption (100 μA – 1 mA)
- Low noise figure
- Gold metallization ensures excellent reliability.

DESCRIPTION

The BFT25A is a silicon npn transistor, primarily intended for use in RF low power amplifiers, such as pocket telephones and paging systems with signal frequencies up to 2 GHz.

The transistor is encapsulated in a 3-pin plastic SOT23 envelope.

PINNING

PIN	DESCRIPTION
Code: V10	
1	base
2	emitter
3	collector

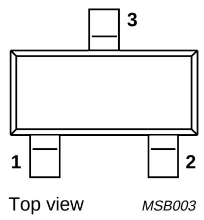


Fig.1 SOT23.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_{CBO}	collector-base voltage	open emitter	–	–	8	V
V_{CEO}	collector-emitter voltage	open base	–	–	5	V
I_C	DC collector current		–	–	6.5	mA
P_{tot}	total power dissipation	up to T_s = 165 °C; note 1	–	–	32	mW
h_{FE}	DC current gain	I_C = 0.5 mA; V_{CE} = 1 V	50	80	200	
f_T	transition frequency	I_C = 1 mA; V_{CE} = 1 V; T_{amb} = 25 °C; f = 500 MHz	3.5	5	–	GHz
G_{UM}	maximum unilateral power gain	I_C = 0.5 mA; V_{CE} = 1 V; T_{amb} = 25 °C; f = 1 GHz	–	15	–	dB
F	noise figure	$\Gamma = \Gamma_{opt}$; I_C = 0.5 mA; V_{CE} = 1 V; T_{amb} = 25 °C; f = 1 GHz	–	1.8	–	dB
		$\Gamma = \Gamma_{opt}$; I_C = 1 mA; V_{CE} = 1 V; T_{amb} = 25 °C; f = 1 GHz	–	2	–	dB

Note

1. T_s is the temperature at the soldering point of the collector tab.

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{CBO}	collector-base voltage	open emitter	–	8	V
V_{CEO}	collector-emitter voltage	open base	–	5	V
V_{EBO}	emitter-base voltage	open collector	–	2	V
I_C	DC collector current		–	6.5	mA
P_{tot}	total power dissipation	up to T_s = 165 °C; note 1	–	32	mW
T_{stg}	storage temperature		–65	150	°C
T_j	junction temperature		–	175	°C

THERMAL RESISTANCE

SYMBOL	PARAMETER	THERMAL RESISTANCE
$R_{th\ j\text{-}s}$	from junction to soldering point (note 1)	260 K/W

Note

1. T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_{CBO}	collector cut-off current	$I_E = 0$; $V_{CB} = 5$ V	–	–	50	nA
h_{FE}	DC current gain	$I_C = 0.5$ mA; $V_{CE} = 1$ V	50	80	200	
f_T	transition frequency	$I_C = 1$ mA; $V_{CE} = 1$ V; $T_{amb} = 25$ °C; f = 500 MHz	3.5	5	–	GHz
C_{re}	feedback capacitance	$I_C = i_c = 0$; $V_{CB} = 1$ V; f = 1 MHz	–	0.3	0.45	pF
G_{UM}	maximum unilateral power gain (note 1)	$I_C = 0.5$ mA; $V_{CE} = 1$ V; $T_{amb} = 25$ °C; f = 1 GHz	–	15	–	dB
F	noise figure	$\Gamma = \Gamma_{opt}$; $I_C = 0.5$ mA; $V_{CE} = 1$ V; $T_{amb} = 25$ °C; f = 1 GHz	–	1.8	–	dB
		$\Gamma = \Gamma_{opt}$; $I_C = 1$ mA; $V_{CE} = 1$ V; $T_{amb} = 25$ °C; f = 1 GHz	–	2	–	dB

Note

1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10\ \log\frac{|S_{21}|^2}{\left(1-|S_{11}|^2\right)\left(1-|S_{22}|^2\right)}\ \text{dB}.$$

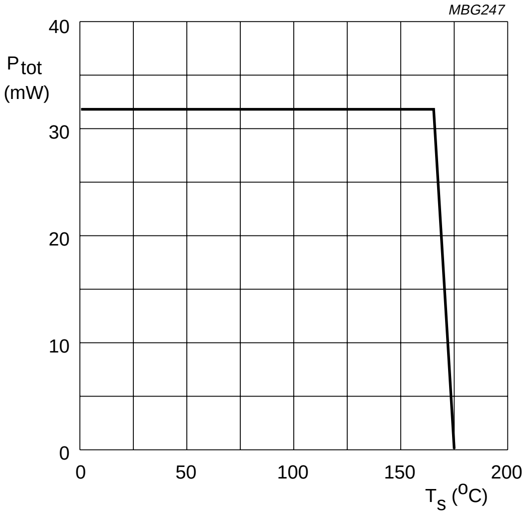
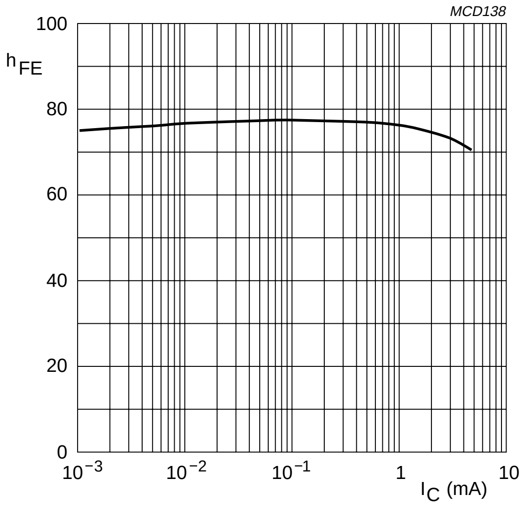
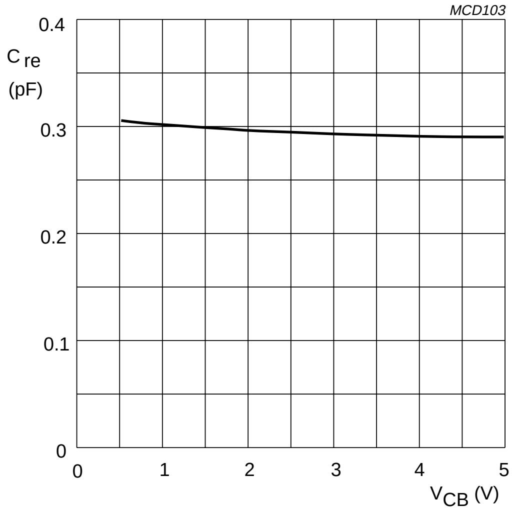


Fig.2 Power derating curve.



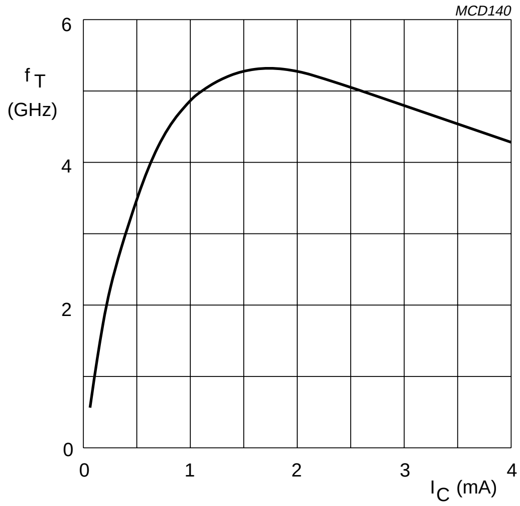
V_{CE} = 1 V.

Fig.3 DC current gain as a function of collector current.



$I_c = i_c = 0$; f = 1 MHz.

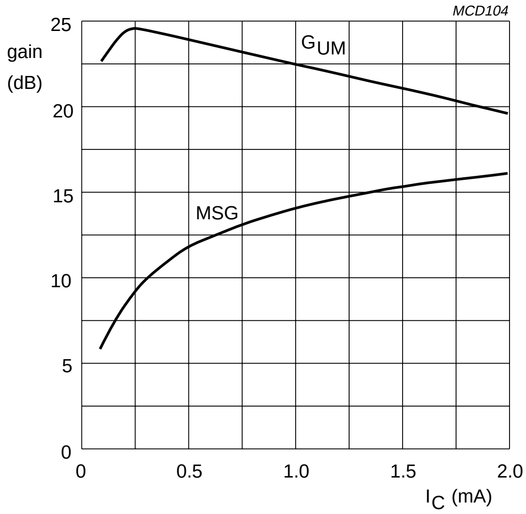
Fig.4 Feedback capacitance as a function of collector-base voltage.



V_{CE} = 1 V; T_{amb} = 25 °C; f = 500 MHz.

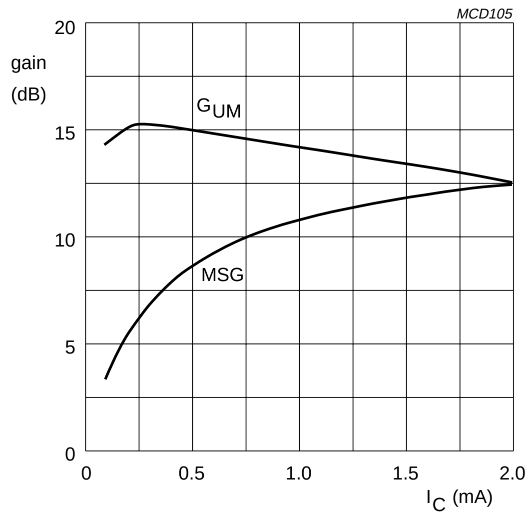
Fig.5 Transition frequency as a function of collector current.

In Figs 6 to 9, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



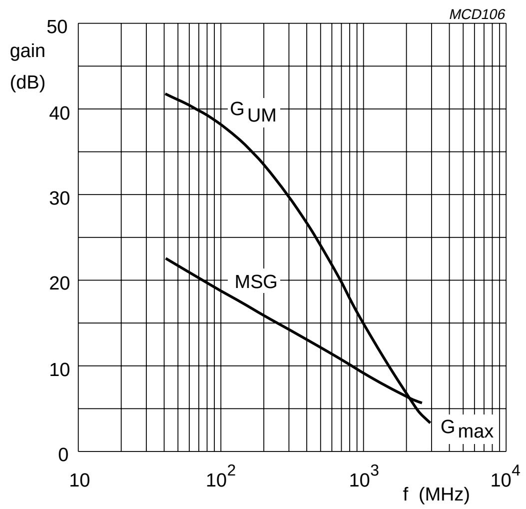
V_{CE} = 1 V; f = 500 MHz.

Fig.6 Gain as a function of collector current.



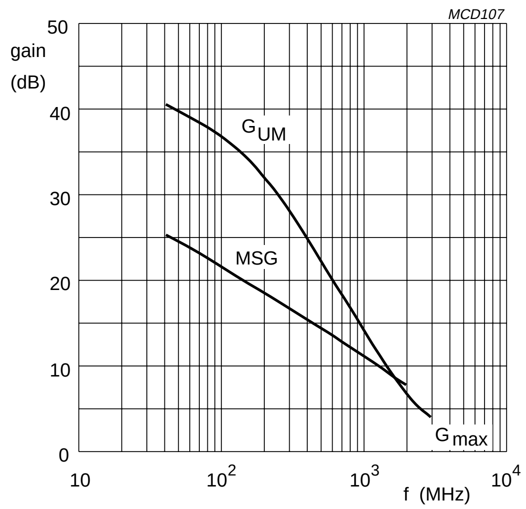
V_{CE} = 1 V; f = 1 GHz.

Fig.7 Gain as a function of collector current.



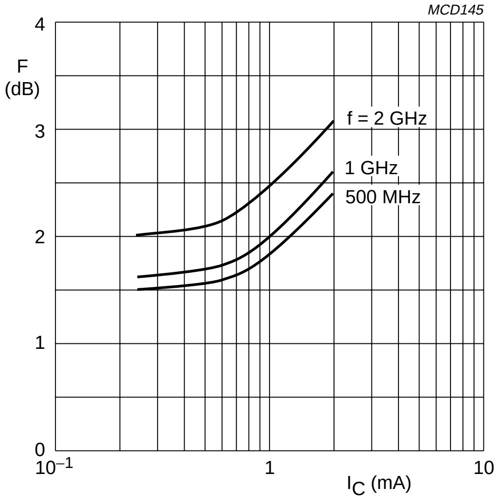
V_{CE} = 1 V; I_c = 0.5 mA.

Fig.8 Gain as a function of frequency.



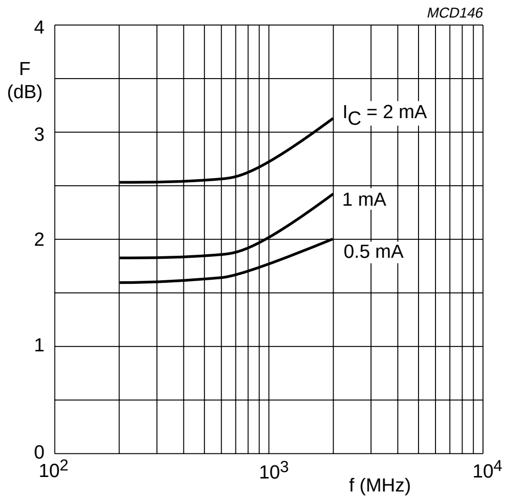
V_{CE} = 1 V; I_c = 1 mA.

Fig.9 Gain as a function of frequency.



V_{CE} = 1 V.

Fig.10 Minimum noise figure as a function of collector current.



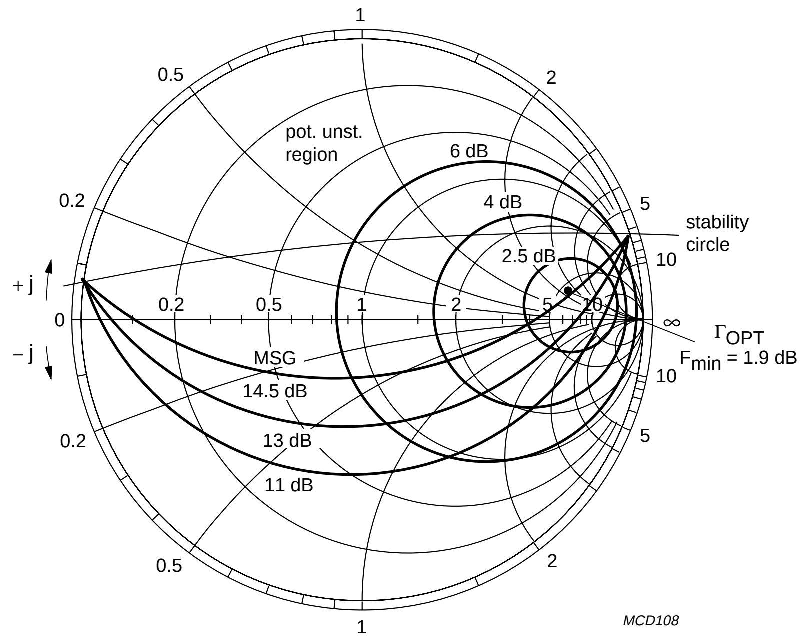
V_{CE} = 1 V.

Fig.11 Minimum noise figure as a function of frequency.

f (MHz)	V_{CE} (V)	I_C (mA)
500	1	1

Noise Parameters

F_{min} (dB)	Gamma (opt)		R_n/50
	(mag)	(ang)	
1.9	0.79	4	2.5



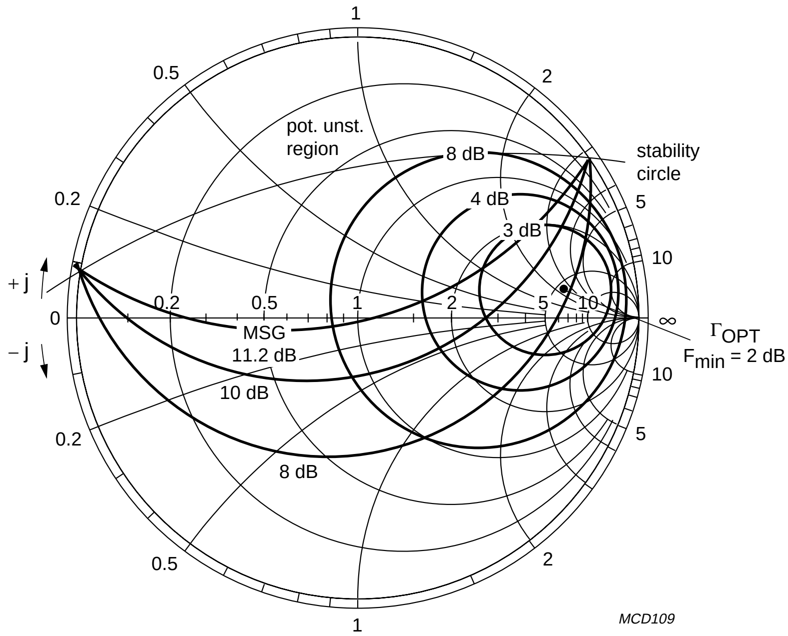
Z_o = 50 Ω.
Average gain parameter: MSG = 14.5 dB.

Fig.12 Noise circle figure.

f (MHz)	V_{CE} (V)	I_C (mA)
1000	1	1

Noise Parameters

F_{min} (dB)	Gamma (opt)		$R_n/50$
	(mag)	(ang)	
2	0.74	8	2.6



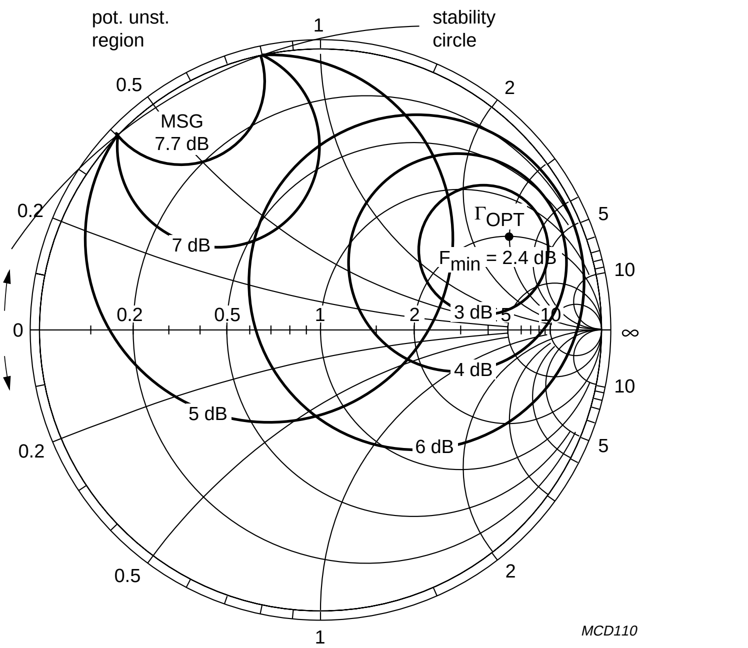
Z_o = 50 Ω.
Average gain parameter: MSG = 11.2 dB.

Fig.13 Noise circle figure.

f (MHz)	V_{CE} (V)	I_C (mA)
2000	1	1

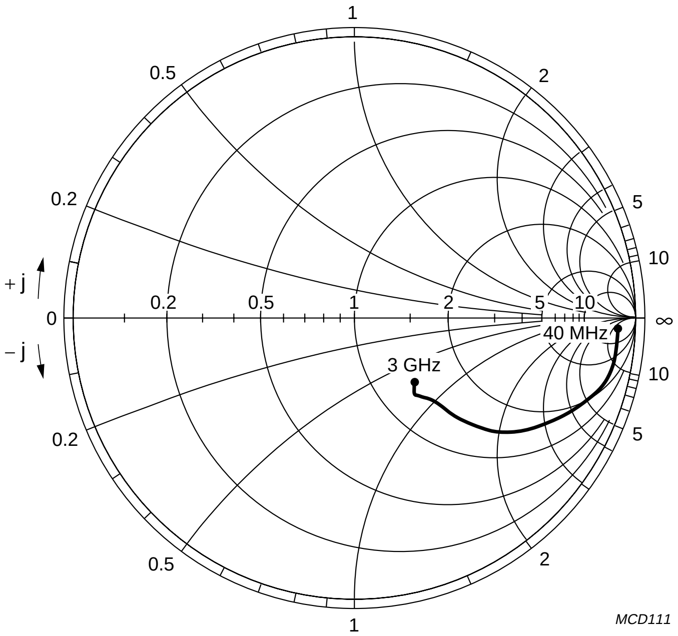
Noise Parameters

F_{min} (dB)	Gamma (opt)		$R_n/50$
	(mag)	(ang)	
2.4	0.72	26	1.7



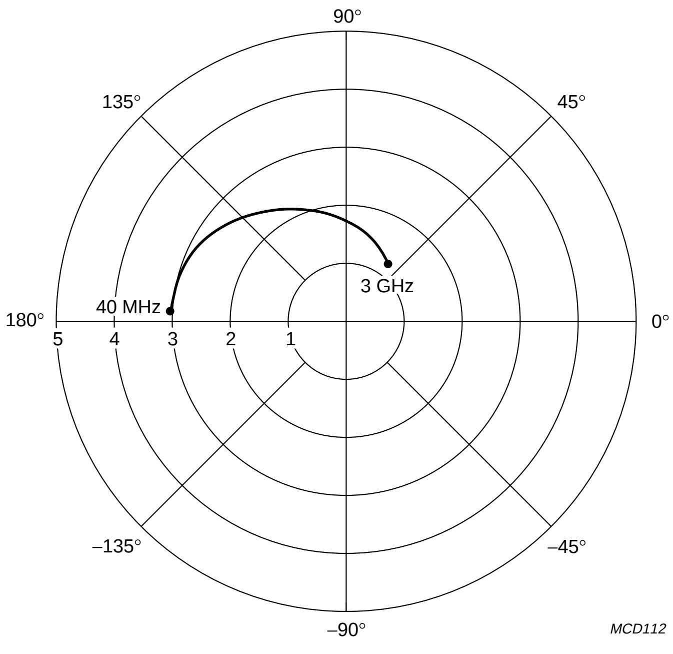
Z_o = 50 Ω.
Average gain parameter: MSG = 7.7 dB.

Fig.14 Noise circle figure.



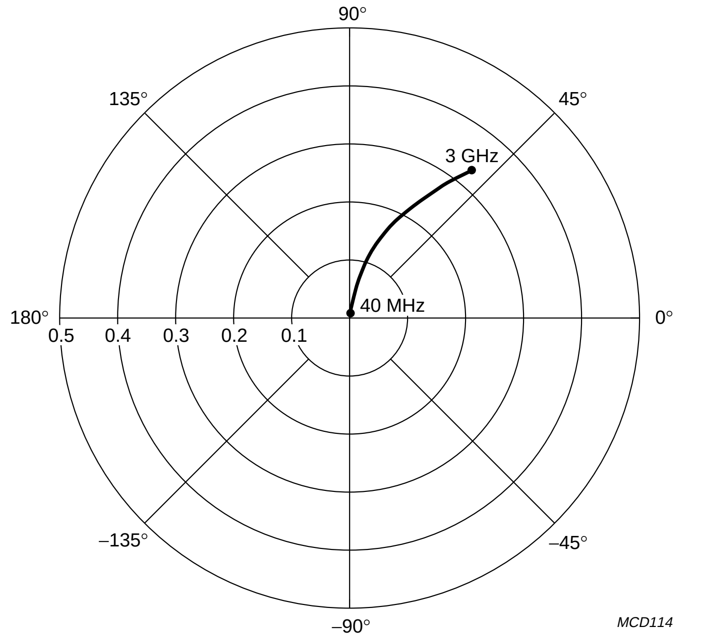
V_{CE} = 1 V; I_C = 1 mA.
Z_o = 50 Ω.

Fig.15 Common emitter input reflection coefficient (S_{11}).



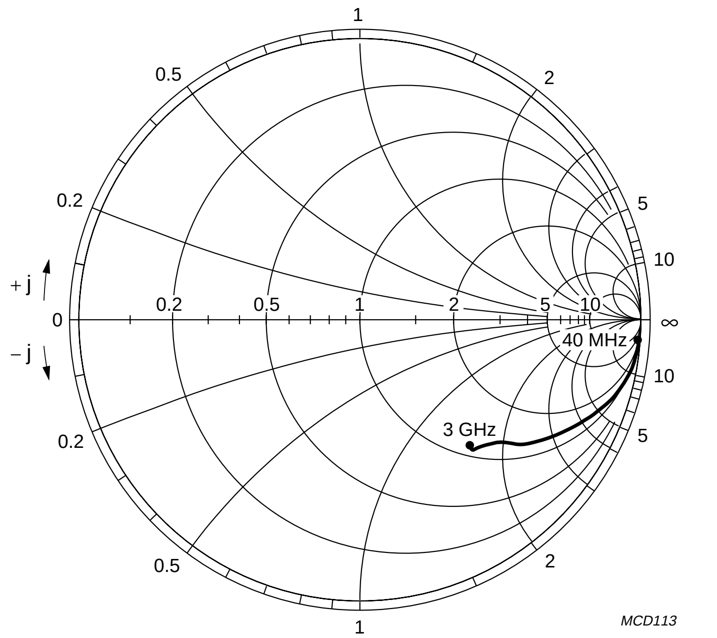
V_{CE} = 1 V; I_C = 1 mA.

Fig.16 Common emitter forward transmission coefficient (S_{21}).



V_{CE} = 1 V; I_C = 1 mA.

Fig.17 Common emitter reverse transmission coefficient (S_{12}).

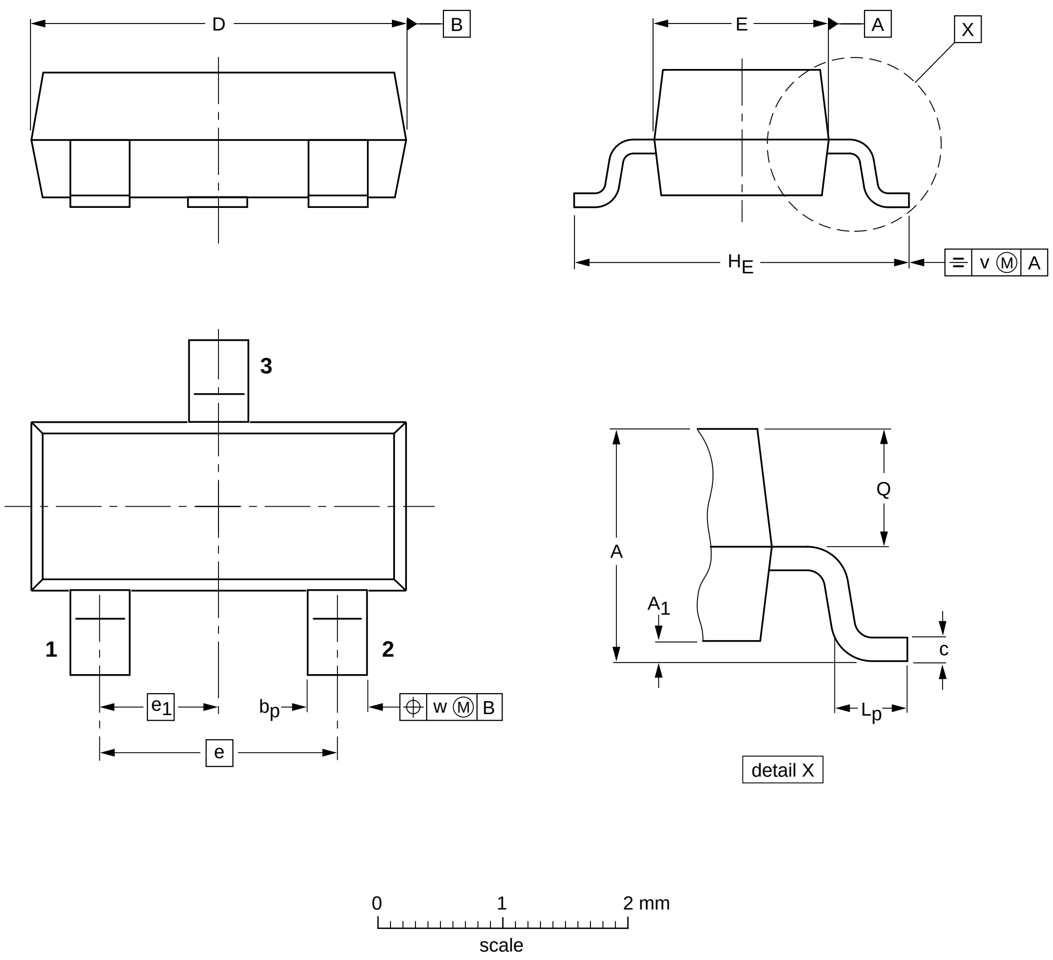


V_{CE} = 1 V; I_C = 1 mA.
Z_o = 50 Ω.

Fig.18 Common emitter output reflection coefficient (S_{22}).

PACKAGE OUTLINE

Plastic surface mounted package; 3 leads **SOT23**



DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1 max.	b_p	c	D	E	e	e_1	H_E	L_p	Q	v	w
mm	1.1 0.9	0.1	0.48 0.38	0.15 0.09	3.0 2.8	1.4 1.2	1.9	0.95	2.5 2.1	0.45 0.15	0.55 0.45	0.2	0.1

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT23						97-02-28

DEFINITIONS

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	
Where application information is given, it is advisory and does not form part of the specification.	

LIFE SUPPORT APPLICATIONS

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